

**N- Channel Enhancement Mode MOSFET****◆ DESCRIPTION**

The MT9406 MOSFET from MATRIX provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

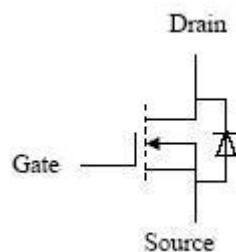
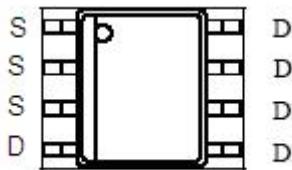
The SO-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

**◆ FEATURES**

- 30V/9A,  $R_{DS(ON)} = 18m\Omega$  @  $V_{GS} = 10V$
- SO-8 package design
- Simple Drive Requirement
- Low On-resistance
- Fast Switching

**◆ APPLICATIONS**

- POWER Management in Note
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch

**◆ PIN CONFIGURATION****◆ ABSOLUTE MAXIMUM RATINGS**

( $T_A=25^\circ C$  Unless Otherwise Noted)

Parameter	Symbol	Maximum	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>3</sup>	$I_D$	9	A
		7.5	
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	50	A
Total Power Dissipation	$P_D$	2.5	W
Linear Derating Factor		0.02	W/ $^\circ C$
Storage Temperature Range	$T_{STG}$	-55 to 150	$^\circ C$
Operating Junction Temperature Range	$T_J$	- 55 to 150	$^\circ C$



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## ◆ THERMAL RESISTANCE RATINGS

Thermal Resistance	Symbol	Maximum	Unit
Thermal Resistance Junction-ambient <sup>3</sup>	R <sub>thj-a</sub>	50	°C/W

## ◆ ELECTRICAL CHARACTERISTICS

(T<sub>A</sub>=25°C Unless Otherwise Noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Parameters</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	30	-	-	V
Breakdown Voltage Temperature Coefficient	ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	Reference to 25 °C, I <sub>D</sub> =1mA	-	0.02	-	V/°C
Static Drain-Source On-Resistance <sup>2</sup>	R <sub>D</sub> <sub>S(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 9A	-	-	18	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7A	-	-	25	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1	-	3	V
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 10V, I <sub>D</sub> = 9A	-	15	-	S
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V	-	-	1	uA
		V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V	-	-	25	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> =±20V	-	-	±100	nA
<b>Dynamic Parameters</b>						
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	I <sub>D</sub> =9A, V <sub>DS</sub> =24V, V <sub>GS</sub> =4.5V	-	8	13	nc
Gate-Source Charge	Q <sub>gs</sub>		-	2	-	
Gate-Drain("Miller")Charge	Q <sub>gd</sub>		-	4	-	
Turn-on Delay Time <sup>2</sup>	t <sub>d(on)</sub>	V <sub>DS</sub> =15V, I <sub>D</sub> =1A, R <sub>G</sub> =3.3Ω, V <sub>GS</sub> =10V, R <sub>D</sub> =15Ω	-	7	-	ns
Rise Time	t <sub>r</sub>		-	6	-	
Turn-off Delay Time	T <sub>d(off)</sub>		-	19	-	
Fall time	T <sub>f</sub>		-	7	-	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz	-	620	1530	pF
Output Capacitance	C <sub>oss</sub>		-	230	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	90	-	
Gate Resistance	R <sub>g</sub>	f=1.0MHz	-	3.2	-	Ω

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◆ **Source-Drain Diode**

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward On Voltage <sup>2</sup>	V <sub>SD</sub>	I <sub>S</sub> =2.1A, V <sub>GS</sub> =0V	-	-	1.2	V
Reverse Recovery Time <sup>2</sup>	t <sub>rr</sub>	I <sub>S</sub> =9A, V <sub>GS</sub> =0V, dI/dt=100A/us	-	24	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>		-	16	-	nc

Notes:

1. Pulse width limited by Max. junction temperature.
2. Pulse width  $\leq$ 300us, duty cycle  $\leq$  2%
3. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board, t  $\leq$ 10sec;125 °C/W when mounted on Min.copper pad.



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## ◆ TYPICAL CHARACTERISTICS

(25°C Unless Noted)

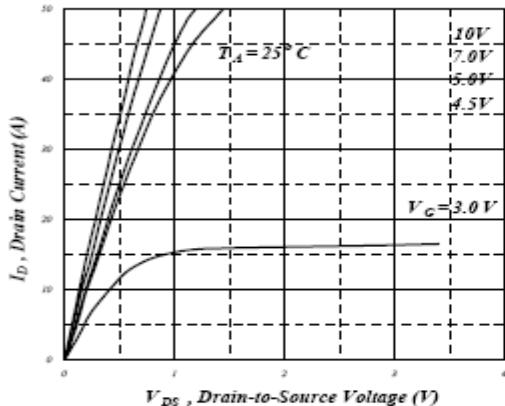


Fig 1. Typical Output Characteristics

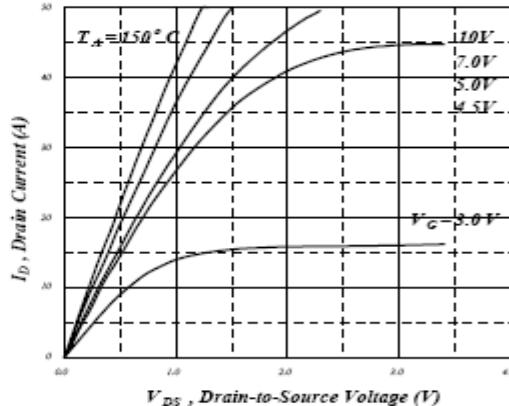


Fig 2. Typical Output Characteristics

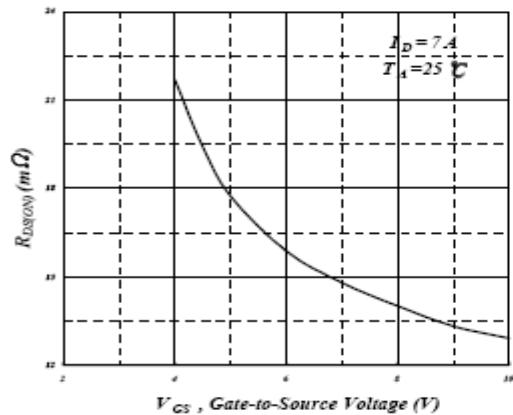


Fig 3. On-Resistance v.s. Gate Voltage

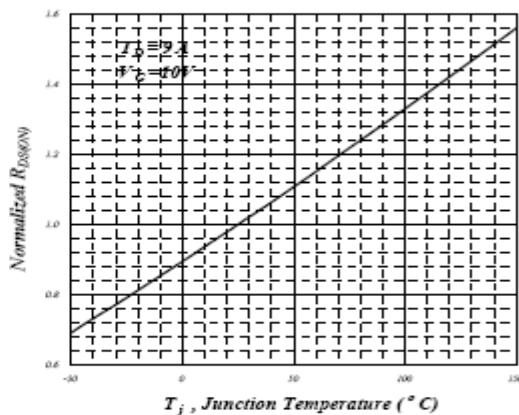


Fig 4. Normalized On-Resistance v.s. Junction Temperature

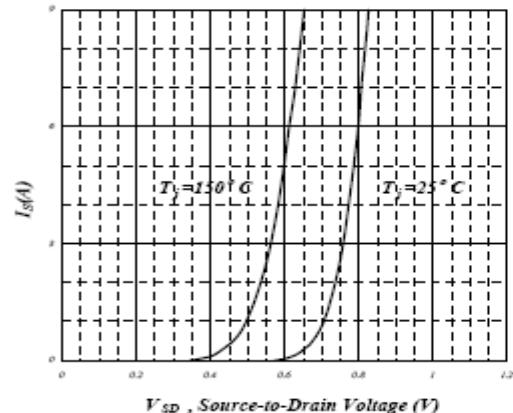


Fig 5. Forward Characteristic of Reverse Diode

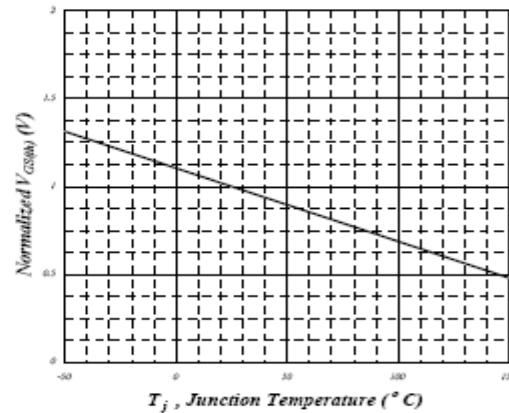


Fig 6. Gate Threshold Voltage v.s. Junction Temperature



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## ◆ TYPICAL CHARACTERISTICS

(25°C Unless Noted)

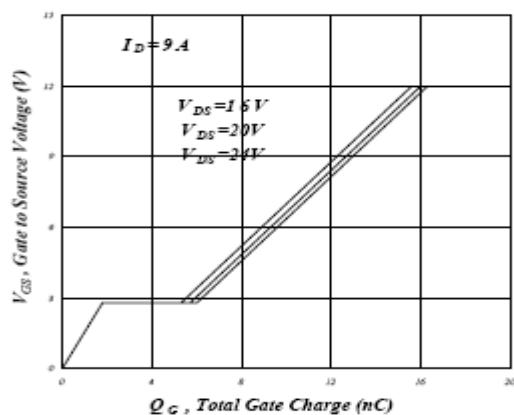


Fig 7. Gate Charge Characteristics

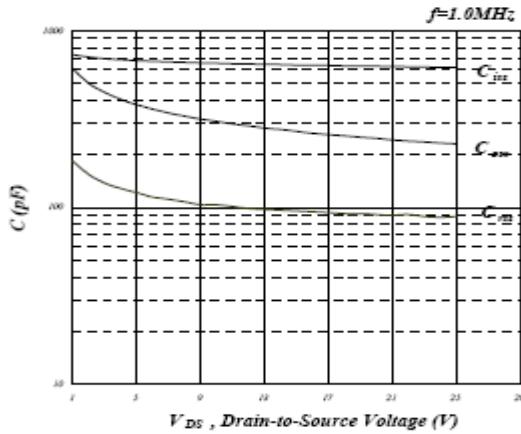


Fig 8. Typical Capacitance Characteristics

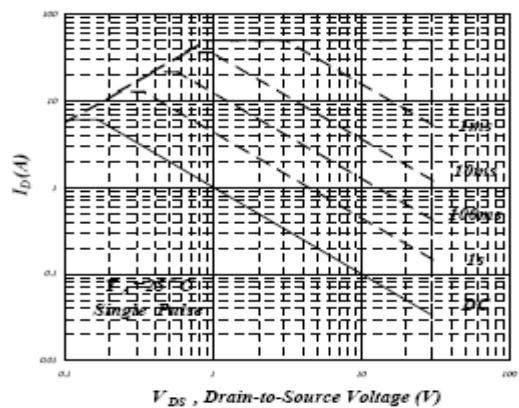


Fig 9. Maximum Safe Operating Area

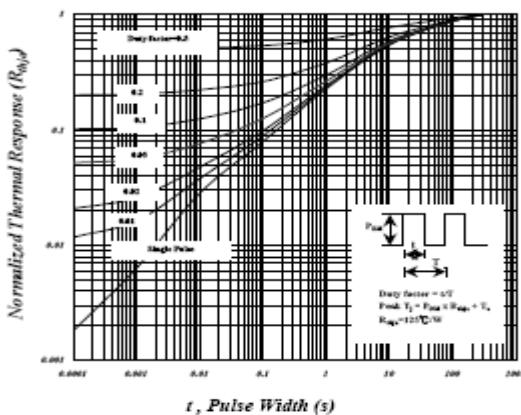


Fig 10. Effective Transient Thermal Impedance

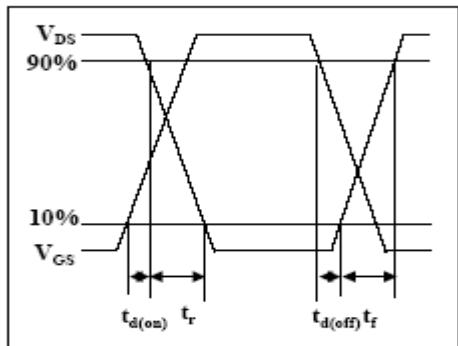


Fig 11. Switching Time Waveform

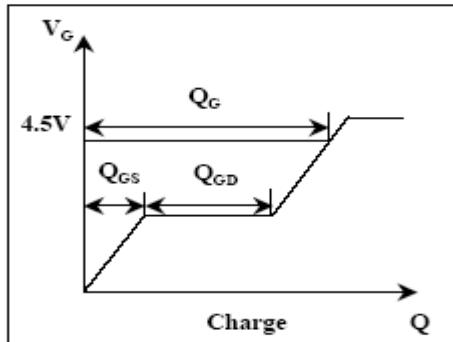


Fig 12. Gate Charge Waveform



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## ◆ PHYSICAL DIMENSIONS:

8-Pin Plastic S.O.I.C. (M)

